

TEMPLATE FILENAME: PRODUCT	SPECISIZE A41(V.1).DOC



1.0 SCOPE	.3
2.0 Applicable Document.	.3
3.0 Requirements.	. 3
4.0 RATINGS	.3
5.0 ELECTRICAL PERFORMANCE	.4
MECHANICAL PERFORMANCE	5
ENVIRONMENTAL PERFORMANCE	6
6.0 PRODUCT Qualification and Pregualification Test Sequence	8

REVISION:	ECR/ECN INFORMATION:	TITLE:	DULIO		SHEET No.
П	EC No: SH2007-0758			2 of 2	
U	<u>DATE:</u> 2007/05/23	CONNECTOR SMT TYPE			2 01 0
DOCUMEN	T NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO	<u>OVED BY:</u>
P	S-48037-001	Donic.Yang			
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USB A TYPE PLUG CONNECTOR

1.0 SCOPE

This specification covers the requirements for product performance and test methods of USB A TYPE (Universal Serial Bus Revision 2.0) Plug Connector.

2.0 PRODUCT DESCRIPTION

2.1 PRODUCT NAME AND SERIES NUMBER(S)

2.1.1 PRODUCT NAME : USB A Type Plug Connector 2.1.2 SERIES NUMBER : 48037 Series

2.2 DIMENSIONS, MATERIALS, PLATINGS AND MARKINGS

See the appropriate Sales Drawings for information on dimensions, materials, platings and markings.

2.3 SAFETY AGENCY APPROVALS

3.0 APPLICABLE DOCUMENTS AND SPECIFICATIONS EIA-364. MIL-STD-202. MIL-STD-1344A. USB 2.0 SPECIFICATIONS

4.0 RATINGS

4.1 VOLTAGE

150 Volts AC (RMS)

4.2 CURRENT

1.5_Amps

4.3 TEMPERATURE

Operating Temperature: - 20°C to + 85°C Stock Temperature : 0~50°C Reliability Temperature : -55°C~85°C

REVISION: D	ECR/ECN INFORMATION: EC No: SH2007-0758 DATE: 2007/05/23	USB A TYPE CONNECTO	PLUG R SMT TYPE		<u>SHEET No.</u> 3 of 8
DOCUMEN	T NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO	<u>OVED BY:</u>
P	S-48037-001	Donic.Yang			
			TEMPLATE FILENAM	E: PRODUCT SPE	CISIZE A41(V.1).DOC



5.0 PERFORMANCE

5.1 APPEARANCE REQUIREMENTS

ITEM	DESCRIPTION	TEST CONDITION	REQUIREMENT
1	Examination of Product	EIA-364-18 Visual inspection	Meets requirements of product drawing. No physical damage.

5.2 ELECTRICAL REQUIREMENTS

ITEM	DESCRIPTION	TEST CONDITION	REQUIREMENT
2	Low Level Contact Resistance	EIA 364-23 Mate connectors: apply a maximum voltage of 20 mV and a current of 100 mA.	30 milliohms MAXIMUM
3	Insulation Resistance	EIA 364-21 Unmate & unmount connectors: apply a voltage of 500 VDC between adjacent terminals and between terminals to ground.	1000 Megohms MINIMUM
4	Dielectric Withstanding Voltage	EIA 364-20 Unmate connectors: apply a voltage of 500 volts VAC for 1 minute between adjacent terminals and between terminals to ground.	No breakdown; current leakage < 0.5 mA
5	Contact Capacitance	EIA-364-30 Test between adjacent circuits of unmated connector at 1 KHz. The object of this test is to detail a standard method to determine the capacitance between conductive elements of a USB connector.	2 pF Maximum per Contact

REVISION:	ECR/ECN INFORMATION:	TITLE:			SHEET No.
Л	EC No: SH2007-0758	USB A TYPE PLUG		A of 8	
U	<u>DATE:</u> 2007/05/23	CONNECTOR SMT TYPE			4010
DOCUMEN	T NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO	OVED BY:
P	S-48037-001	Donic.Yang			
	TEMPLATE FILENAME: PRODUCT_SPEC(SIZE_A4](V.1).DOC				



		EIA 364-70 Method B	
	Contact Current	When measured at an ambient	
		temperature of 25° C. With Power applied	
		to the contacts, the ΔT shall not exceed +	
		applied to the contacts, the $30^\circ\!\mathrm{C}$ at any	1.5A at 250Vac minimum &
6 Rating	point in the USB connector under test	Temperature rise:	
	The object of this test procedure is to	+30°C MAXIMUM	
		detail a standard method to assess the	
		current caring capacity of mated USB	
		connector contacts.	

5.3 MECHANICAL REQUIREMENTS (continued)

ITEM	DESCRIPTION	TEST CONDITION	REQUIREMENT
Conn	Connector Mate	EIA 364-13 Mate and unmate connector (male to	Mating Force : 35 N MAXIMUM
Unmate Forces		female) at maximum a rate of 12.5 mm (0.492 inch) per minute.	Unmating Force : 10 N MINIMUM
8	Durability	EIA-364-09 Mate and unmate Connector assemblies for 1500 cycles at maximum rated of 200 cycles per bour	1) Shall meet visual requirement, show no physical damage
			2) 30 milliohms MAXIMUM
			1).No discontinuities of 1 us
			microsecond or longer
		EIA-364-09 Test Condition V Test Letter A Mate connectors and subject to 5 35 Gs RMS	duration
9	Vibration (Pandom)	For a period of 15 minutes in each of 3	Mating Force : 35 N MAXIMUM Unmating Force : 10 N MINIMUM) Shall meet visual equirement, show no physical amage 2) 30 milliohms MAXIMUM).No discontinuities of 1 us microsecond or longer duration).Shall meet visual requirement, show no physical damage.) 30 milliohms MAXIMUM
	(Kanuoni)	mutually perpendicular axes.	requirement, show no
			physical damage.
			3) 30 milliohms MAXIMUM

REVISION:	ECR/ECN INFORMATION: EC No: SH2007-0758 DATE: 2007/05/23	USB A TYPE CONNECTO	PLUG R SMT TYPE		<u>SHEET No.</u> 5 of 8
DOCUMEN	T NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO	<u>OVED BY:</u>
P	S-48037-001	Donic.Yang			
	TEMPLATE FILENAME: PRODUCT_SPEC[SIZE_A4](V.1).DOC				



			1).No discontinuities of 1 us
		EIA 364-27 Test Condition H	microsecond or longer
		Subject mated connectors to 30G's half-	duration
10 ^M	Mechanical Shock	sine shock pulses of 11ms duration. Three	2).Shall meet visual
		shocks in each direction applied along	requirement, show no
		total shock.	physical damage.
			3) 30 milliohms MAXIMUM
11	Cable Pull-out Force	EIA 364-38 Test condition A Shall be measured with TENSION GAUGE or TENSION TESTER in same direction.	40 Newtons to the connector for 1 minute.

5.4 ENVIRONMENTAL REQUIREMENTS

	TEM	I DESCRIPTION	TEST CONDITION		REQUIREMENT			
	12	12 Humidity EIA 364-31 Test condition A method III Subject mated connectors to Duration : 168 hours temperature between -25°C to +65°C with 90 to 95% RH 4		 Dielectric Withstanding Voltage: No Breakdown at 500 VAC Insulation Resistance: 1000 Megohms MINIMUM Visual: No Damage 30 milliohms MAXIMUM 				
	13	Shock (Thermal)	EIA 364-32, Test Condition I Subject mated connectors to ten cycles between -55° C to $+85^{\circ}$ C.		 Dielectric Withstanding Voltage: No Breakdown at 500 VAC Insulation Resistance: 1000 Megohms MINIMUM Visual: No Damage 30 milliohms MAXIMUM 			
	14	Temperature Life	EIA 364-17 Test Condition Subject mated connectors t life at 85° $\mathbb C$ for 500hours	a 2 Method A o temperature	 30 milliohms MAXII 2).Shall meet visual requirement, show r physical damage. 		MUM	
	15	Mixed Flowing Gas	EIA 364-65 Class IIA Exposures Cl2;10 \pm 3 NO2; 200 \pm 50 H2S;10 \pm 5 (ppb),SO2; 100 \pm 20 1). Mating Conditions : 5 days. 2). Unmated: 5 days Mated Temperature : 30 \pm 1 $^{\circ}$ C, Humidity : 70 \pm 2%R.H.		 Shall meet visual requirement, show no physica damage. Shall meet requirements of additional tests 30 milliohms MAXIMUM 		o physical ments of KIMUM	
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DOCU	DOCUMENT NUMBER: PS-48037-001		CREATED / REVISED BY: Donic.Yang	CHECKE	<u>) BY:</u>		OVED BY:	



16	Solderability	EIA 364-52 connector terminal tails in solder: (held at $245\pm5^{\circ}$ C) up to 0.5mm from the bottom of the housing for 5± 0.5 sec.	The surface of the portion to be soldered shall at least 95% covered with new solder coating
17	Resistance To Soldering Heat	REFLOW SOLDERING : Pre-heat: 150~200°C for 120 sec : 230°C 20~40secREFLOW: 260 \pm 5 °C 10sec $260°C$ (Peak) Temp / Time c $260°C$	No mechanical defect on housing or other parts
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/ISION: D	ECR/ECN INFORMATION EC No: SH2007-0758 DATE: 2007/05/23		- <u>SHEET 1</u> 7 of 8
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6.0 PRODUCT Qualification and Requalification Test Sequence

TEST SEQUENCES IDENTIFICATION

Test Group		Sample Groups							
Item	Test Description	Α	В	С	D	Е	F	G	
1	Examination of product	1 10	1 5	17	19	13	13	13	
2	Low Level Contact Resistance	37	2 4	246					
3	Insulation Resistance				37				
4	Dielectric Withstanding Voltage				48				
5	Contact Capacitance				2				
6	Contact Current Rating						2		
7	Mating & Unmating Force	28							
8	Durability	4							
9	Random Vibration	6							
10	Mechanical Shock	5							
11	Cable Pull-out Force	9							
12	Humidity				5				
13	Thermal Shock				6				
14	Temperature Life		3						
15	Mixed Flowing Gas			35					
16	Solderability					2			
17	Resistance to solder heat							2	
Number of Test Samples (Minimum)		8	8	8	8	8	8	8	

Note:

a. Samples shall be prepare in accordance with applicable manufacture's instructions and shall be selected at random

from current production.

b. Precondition samples with 3 cycles durability.

c. All the tests shall be performed in the sequence.

REVISION:	ECR/ECN INFORMATION:	TITLE:	BULLO		SHEET No.
D	<u>EC No:</u> SH2007-0758 DATE: 2007/05/23	CONNECTO	8 of 8		
DOCUMEN	T NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO	<u>OVED BY:</u>
PS-48037-001		Donic.Yang			
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